

## **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Drain-Source Voltage		$V_{DSS}$	60	V
Gate-Source Voltage		$V_{GSS}$	±16	V
Continuous Drain Current (Note 6)	$T_A = +25^{\circ}C$ $T_A = +100^{\circ}C$	Ι <sub>D</sub>	11.76 8.3	А
Continuous Drain Current (Note 7)	$T_{C} = +25^{\circ}C$ $T_{C} = +100^{\circ}C$	Ι <sub>D</sub>	89.5 63.3	А
Maximum Continuous Body Diode Forward Current (Note 7)		Is	89	Α
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)		I <sub>DM</sub>	350	Α
Pulsed Body Diode Forward Current (380µs Pulse, Duty Cycle = 1%)		I <sub>SM</sub>	350	Α
Avalanche Current, L=0.1mH		I <sub>AS</sub>	20.3	Α
Avalanche Energy, L=0.1mH		E <sub>AS</sub>	20.6	mJ

## **Thermal Characteristics**

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 6)	$T_A = +25$ °C	$P_{D}$	2.8	W
Thermal Resistance, Junction to Ambient (Note 6)		$R_{\Theta JA}$	53	°C/W
Total Power Dissipation (Note 7)	$T_C = +25$ °C	$P_D$	136	W
Thermal Resistance, Junction to Case (Note 7)		R <sub>OJC</sub>	1.1	°C/W
Operating and Storage Temperature Range		$T_{J_i}T_{STG}$	-55 to +175	°C

## Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

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Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)		1		1	1		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	_	_	V	$V_{GS} = 0V$ , $I_D = 1mA$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 48V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	$V_{GS(TH)}$	0.7		2	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance		_	7.2	10	mΩ	$V_{GS} = 10V, I_D = 20A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	8.9	12	11177	$V_{GS} = 4.5V, I_D = 15A$	
Diode Forward Voltage	V <sub>SD</sub>	_	0.9	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 20A	
DYNAMIC CHARACTERISTICS (Note 9)		•				•	
Input Capacitance	C <sub>ISS</sub>	_	1,925	_		$V_{DS} = 30V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Output Capacitance	Coss	_	438	_	pF		
Reverse Transfer Capacitance	C <sub>RSS</sub>	_	41	_			
Gate Resistance	R <sub>G</sub>	_	1.7	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_G$	_	33.5	_			
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_G$	_	15.6	_	nC	V <sub>DS</sub> = 30V, I <sub>D</sub> = 13.5A	
Gate-Source Charge	Q <sub>GS</sub>	_	4.7	_	IIC		
Gate-Drain Charge	$Q_GD$	_	5.3				
Turn-On Delay Time	t <sub>D(ON)</sub>	_	4.5	_		$V_{DD} = 30V, V_{GS} = 10V,$ $R_G = 6\Omega, I_D = 13.5A$	
Turn-On Rise Time	t <sub>R</sub>	_	8.6	_			
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	35.9	_	ns		
Turn-Off Fall Time	t <sub>F</sub>	_	15.7	_			
Body Diode Reverse Recovery Time	t <sub>RR</sub>	_	18.2	_	ns		
Body Diode Reverse Recovery Charge	$Q_{RR}$	_	33.1	_	nC	$I_F = 13.5A$ , di/dt = 400A/ $\mu$ s	

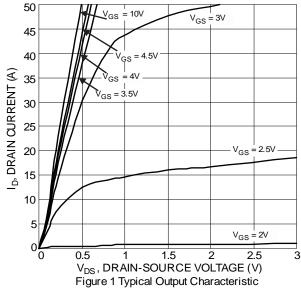
2 of 7

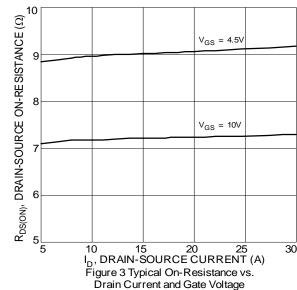
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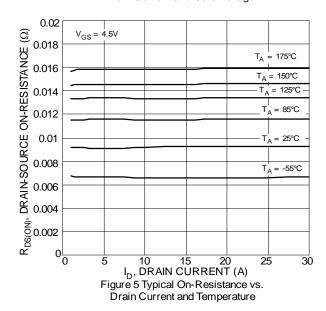
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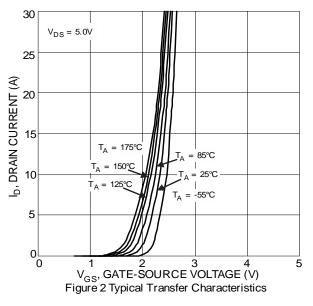
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1-inch square copper plate.
- 7. Thermal resistance from junction to soldering point (on the exposed drain pad).
- 8. Short duration pulse test used to minimize self-heating effect.
- 9. Guaranteed by design. Not subject to product testing.

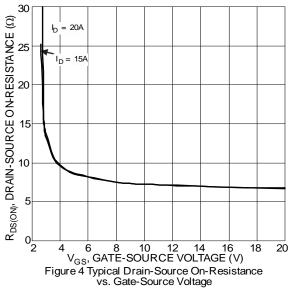


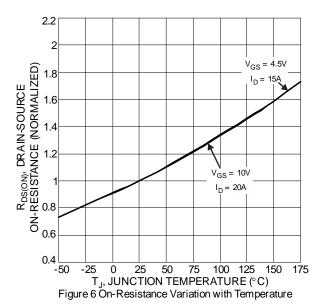




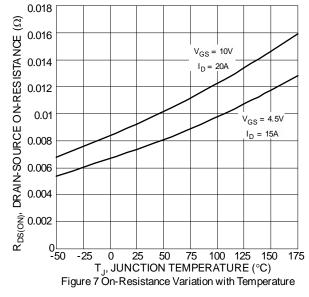


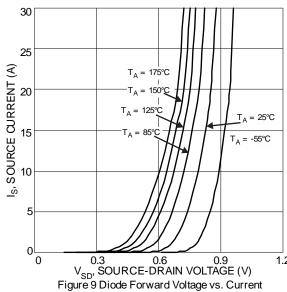


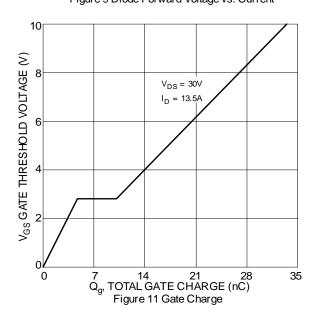


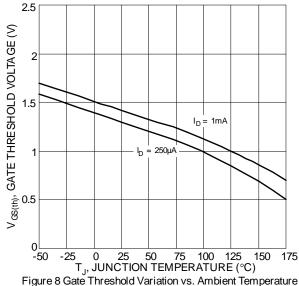


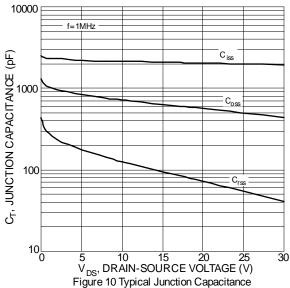


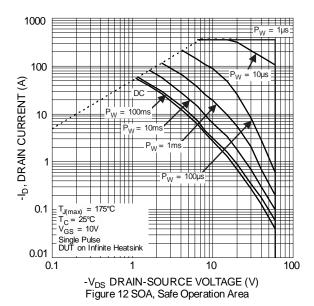




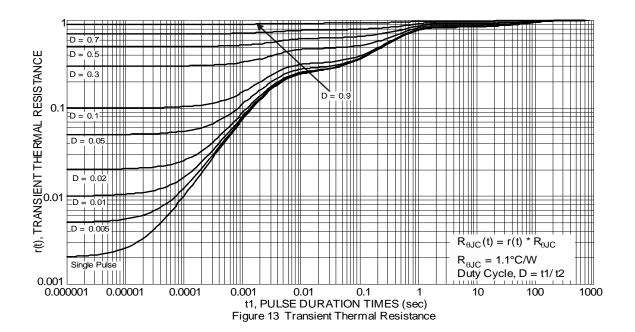








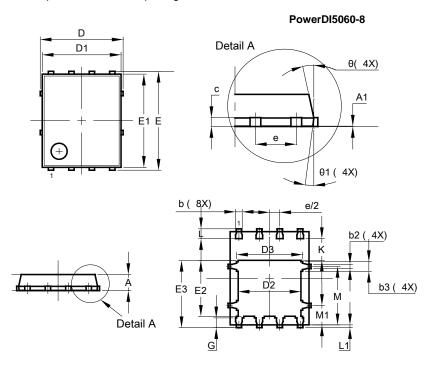






## **Package Outline Dimensions**

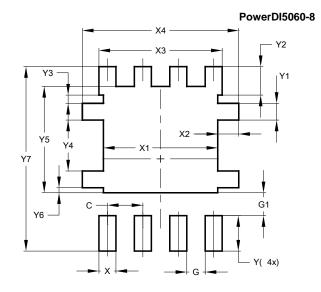
Please see http://www.diodes.com/package-outlines.html for the latest version.



PowerDI5060-8					
Dim	Min Max		Тур		
Α	0.90	1.10	1.00		
A1	0.00	0.05	-		
b	0.33	0.51	0.41		
b2	0.200	0.350	0.273		
b3	0.40	0.80	0.60		
С	0.230	0.330	0.277		
D	5.15 BSC				
D1	4.70	5.10	4.90		
D2	3.70	4.10	3.90		
D3	3.90	4.30	4.10		
Е	(	6.15 BSC	,		
E1	5.60	6.00	5.80		
E2	3.28	3.68	3.48		
E3	3.99	4.39	4.19		
е	1.27 BSC				
G	0.51	0.71	0.61		
K	0.51	-	_		
L	0.51	0.71	0.61		
L1	0.100	0.200	0.175		
M	3.235	4.035	3.635		
M1	1.00	1.40	1.21		
θ	10°	12°	11°		
θ1	6°	8°	7°		
All Dimensions in mm					

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
С	1.270
G	0.660
G1	0.820
Х	0.610
X1	4.100
X2	0.755
Х3	4.420
X4	5.610
Υ	1.270
Y1	0.600
Y2	1.020
Y3	0.295
Y4	1.825
Y5	3.810
Y6	0.180
Y7	6.610



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